


**AO4709**
**P-Channel Enhancement Mode Field Effect Transistor  
with Schottky Diode**
**General Description**

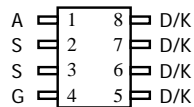
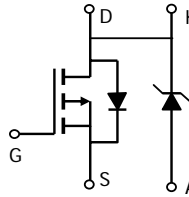
The AO4709 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. A Schottky diode is provided to facilitate the implementation of non-synchronous DC-DC converters. *Standard Product AO4709 is Pb-free (meets ROHS & Sony 259 specifications). AO4709L is a Green Product ordering option. AO4709 and AO4709L are electrically identical.*

**Features**

$V_{DS} (V) = -30V$   
 $I_D = -8A (V_{GS} = -10V)$   
 $R_{DS(ON)} < 33m\Omega (V_{GS} = -10V)$   
 $R_{DS(ON)} < 56m\Omega (V_{GS} = -4.5V)$

**SCHOTTKY**

$V_{DS} (V) = 30V, I_F = 3A, V_F < 0.5V @ 1A$


**SOIC-8**

**Absolute Maximum Ratings  $T_A=25^\circ C$  unless otherwise noted**

| Parameter                               | Symbol         | MOSFET           | Schottky   | Units      |
|---|----------------|------------------|------------|------------|
| Drain-Source Voltage                    | $V_{DS}$       | -30              |            | V          |
| Gate-Source Voltage                     | $V_{GS}$       | $\pm 20$         |            | V          |
| Continuous Drain Current <sup>A</sup>   | $I_D$          | $T_A=25^\circ C$ | -8         | A          |
|   |                | $T_A=70^\circ C$ | -6.6       |            |
| Pulsed Drain Current <sup>B</sup>       | $I_{DM}$       | -40              |            |            |
| Schottky reverse voltage                | $V_{KA}$       |                  | 30         | V          |
| Continuous Forward Current <sup>A</sup> | $I_F$          | $T_A=25^\circ C$ | 4.4        | A          |
|   |                | $T_A=70^\circ C$ | 3.2        |            |
| Pulsed Forward Current <sup>B</sup>     | $I_{FM}$       |                  | 30         |            |
| Power Dissipation                       | $P_D$          | $T_A=25^\circ C$ | 3          | W          |
|   |                | $T_A=70^\circ C$ | 2          |            |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$ | -55 to 150       | -55 to 150 | $^\circ C$ |

| Parameter: Thermal Characteristics MOSFET |              | Symbol          | Typ | Max | Units        |
|---|--------------|-----------------|-----|-----|--------------|
| Maximum Junction-to-Ambient <sup>A</sup>  | $t \leq 10s$ | $R_{\theta JA}$ | 24  | 40  | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup>  | Steady-State |                 | 54  | 75  |              |
| Maximum Junction-to-Lead <sup>C</sup>     | Steady-State | $R_{\theta JL}$ | 21  | 30  |              |
| Thermal Characteristics Schottky          |              |                 |     |     |              |
| Maximum Junction-to-Ambient <sup>A</sup>  | $t \leq 10s$ | $R_{\theta JA}$ | 36  | 40  | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup>  | Steady-State |                 | 67  | 75  |              |
| Maximum Junction-to-Lead <sup>C</sup>     | Steady-State | $R_{\theta JL}$ | 25  | 30  |              |

Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                             | Conditions  | Min  | Typ                | Max              | Units |
|-----------------------------|---------------------------------------|---|------|--------------------|------------------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |   |      |                    |                  |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V   | -30  |                    |                  | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C  |      |                    | -1<br>-5         | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V  |      |                    | ±100             | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA   | -1.2 | -2                 | -2.4             | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V   | 40   |                    |                  | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =-10V, I <sub>D</sub> =-8A<br>T <sub>J</sub> =125°C   |      | 24.5<br>33         | 33               | mΩ    |
|                             |                                       | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-5A   |      | 41                 | 56               | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =-5V, I <sub>D</sub> =-8A   |      | 14.5               |                  | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =-1A, V <sub>GS</sub> =0V  |      | -0.76              | -1               | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |   |      |                    | -4.2             | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |      |                    |                  |       |
| C <sub>iss</sub>            | Input Capacitance                     |   |      | 920                |                  | pF    |
| C <sub>oss</sub>            | Output Capacitance                    | V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz  |      | 190                |                  | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |   |      | 122                |                  | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz  |      | 3.6                |                  | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |   |      |                    |                  |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge (10V)               |   |      | 18.4               |                  | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge (4.5V)              | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-8A   |      | 9.3                |                  | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |   |      | 2.7                |                  | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |   |      | 4.9                |                  | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     |   |      | 7.1                |                  | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, R <sub>L</sub> =1.8Ω,   |      | 3.4                |                  | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    | R <sub>GEN</sub> =3Ω  |      | 18.9               |                  | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |   |      | 8.4                |                  | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =-8A, di/dt=100A/μs  |      | 21.5               |                  | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =-8A, di/dt=100A/μs  |      | 12.5               |                  | nC    |
| <b>SCHOTTKY PARAMETERS</b>  |                                       |   |      |                    |                  |       |
| V <sub>F</sub>              | Forward Voltage Drop                  | I <sub>F</sub> =1.0A  |      | 0.45               | 0.5              | V     |
| I <sub>rm</sub>             | Maximum reverse leakage current       | V <sub>R</sub> =30V<br>V <sub>R</sub> =30V, T <sub>J</sub> =125°C<br>V <sub>R</sub> =30V, T <sub>J</sub> =150°C |      | 0.007<br>3.2<br>12 | 0.05<br>10<br>20 | mA    |
| C <sub>T</sub>              | Junction Capacitance                  | V <sub>R</sub> =15V   |      | 37                 |                  | pF    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

D: The static characteristics in Figures 1 to 6,12,14 are obtained using 80 μs pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating. Rev 4: Sept 2005

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P-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

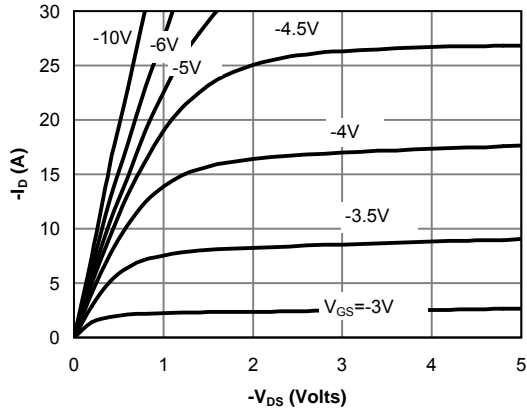


Fig 1: On-Region Characteristics

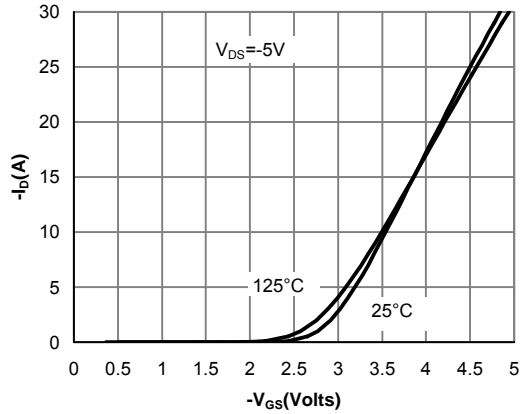


Figure 2: Transfer Characteristics

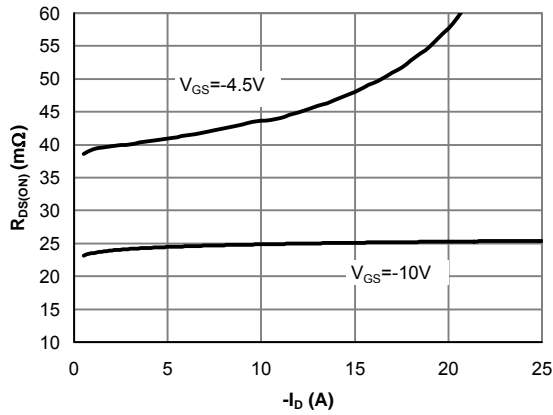


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

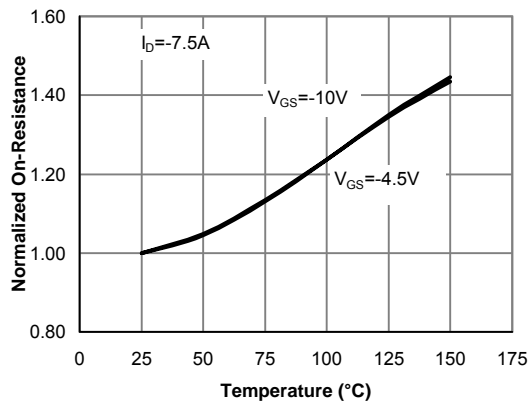


Figure 4: On-Resistance vs. Junction Temperature

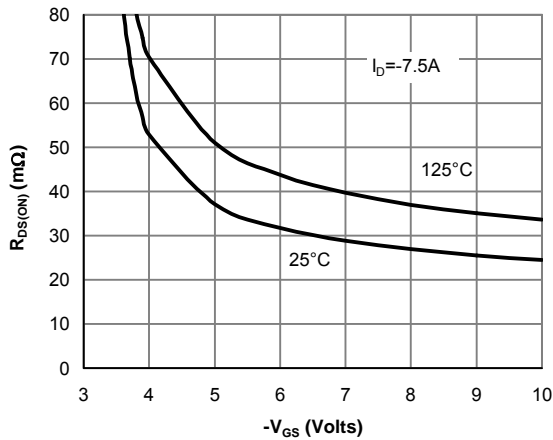


Figure 5: On-Resistance vs. Gate-Source Voltage

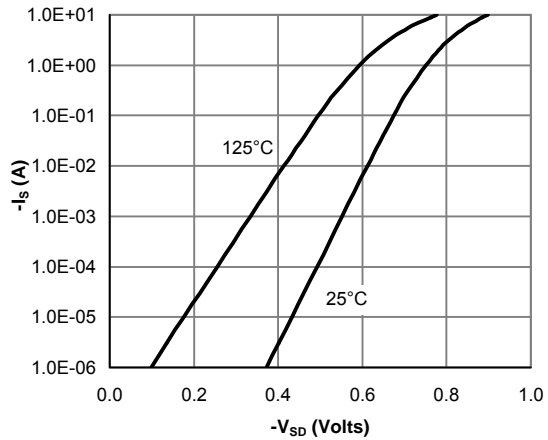


Figure 6: Body-Diode Characteristics

P-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

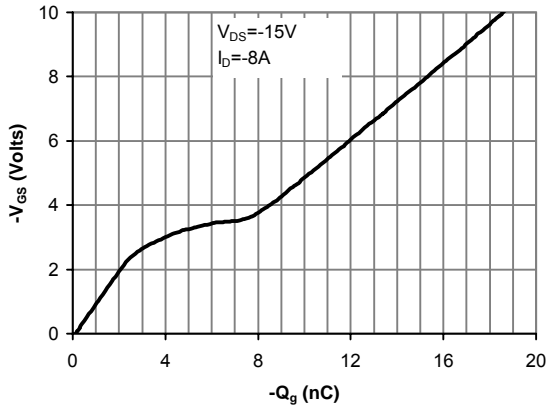


Figure 7: Gate-Charge Characteristics

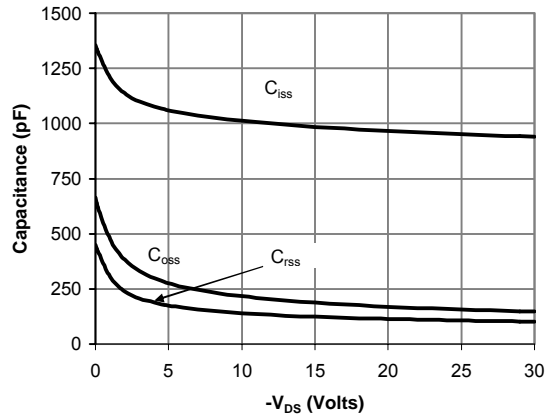


Figure 8: Capacitance Characteristics

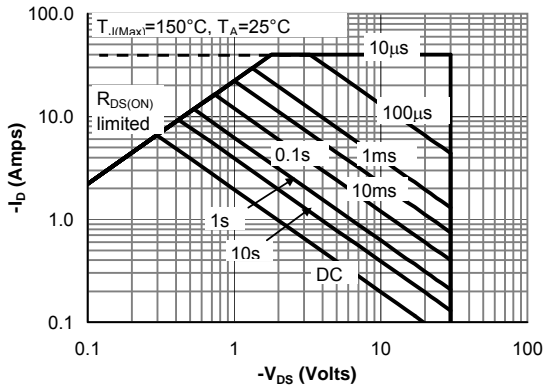


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

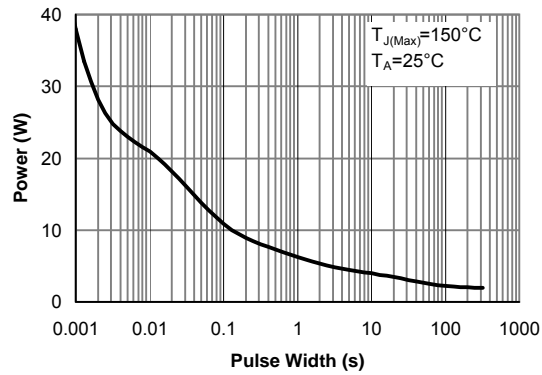


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

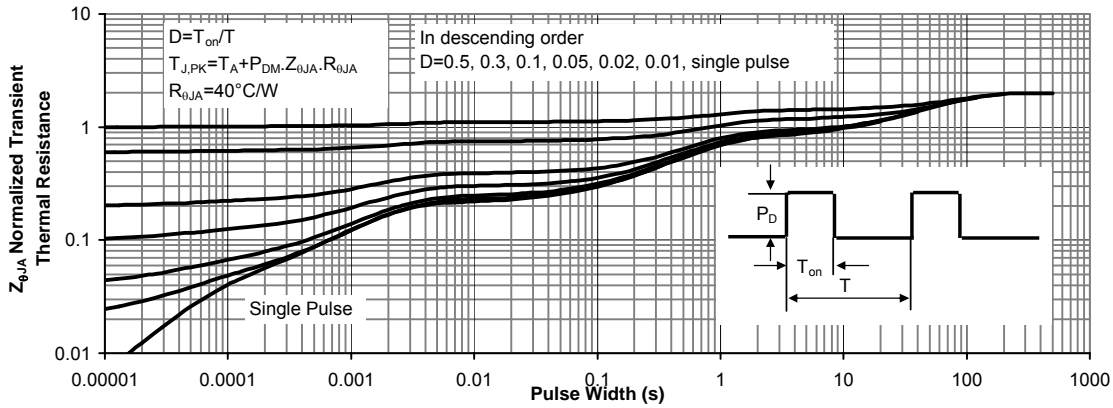


Figure 11: Normalized Maximum Transient Thermal Impedance

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: SCHOTTKY

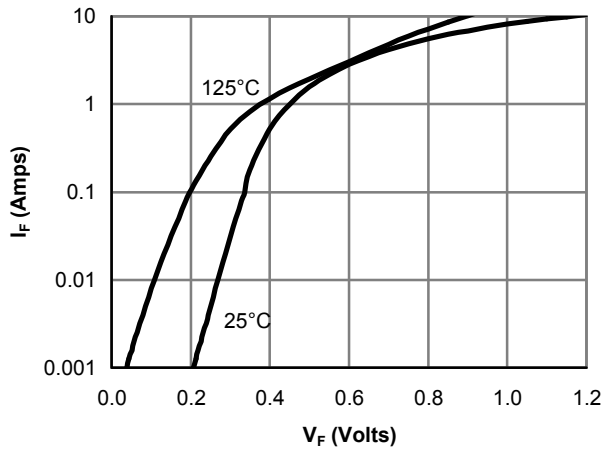


Figure 12: Schottky Forward Characteristics

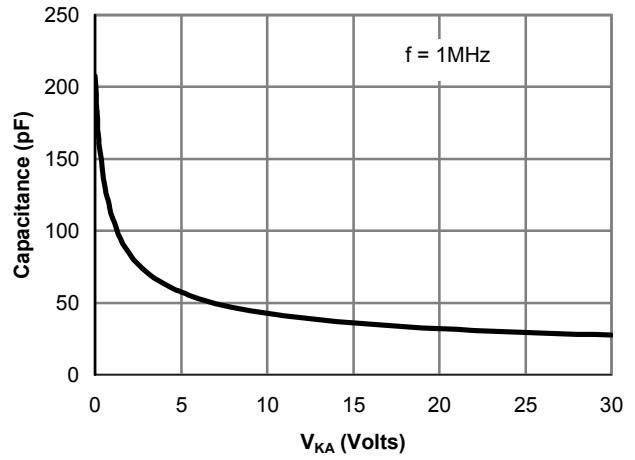


Figure 13: Schottky Capacitance Characteristics

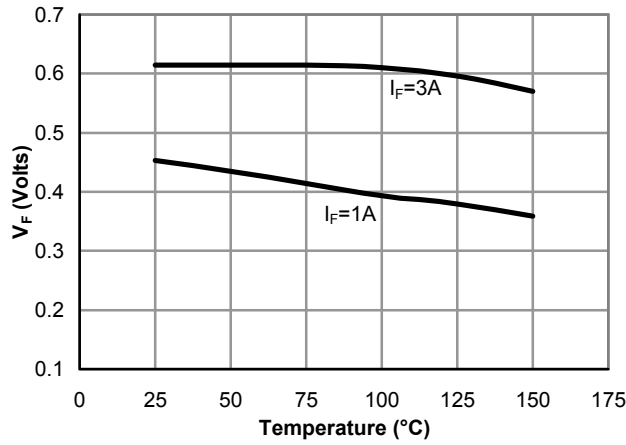


Figure 14: Schottky Forward Drop vs. Junction Temperature

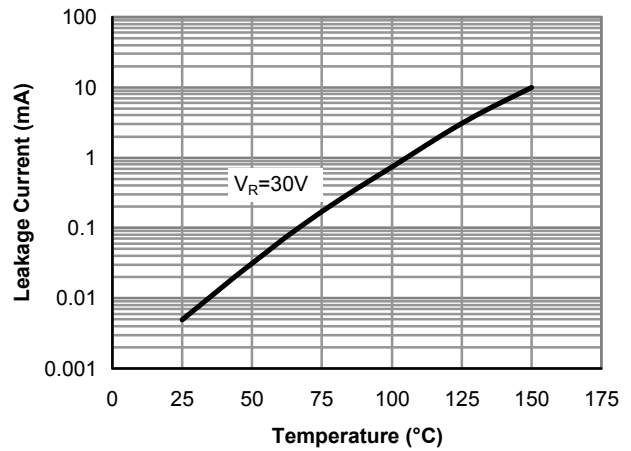


Figure 15: Schottky Leakage current vs. Junction Temperature

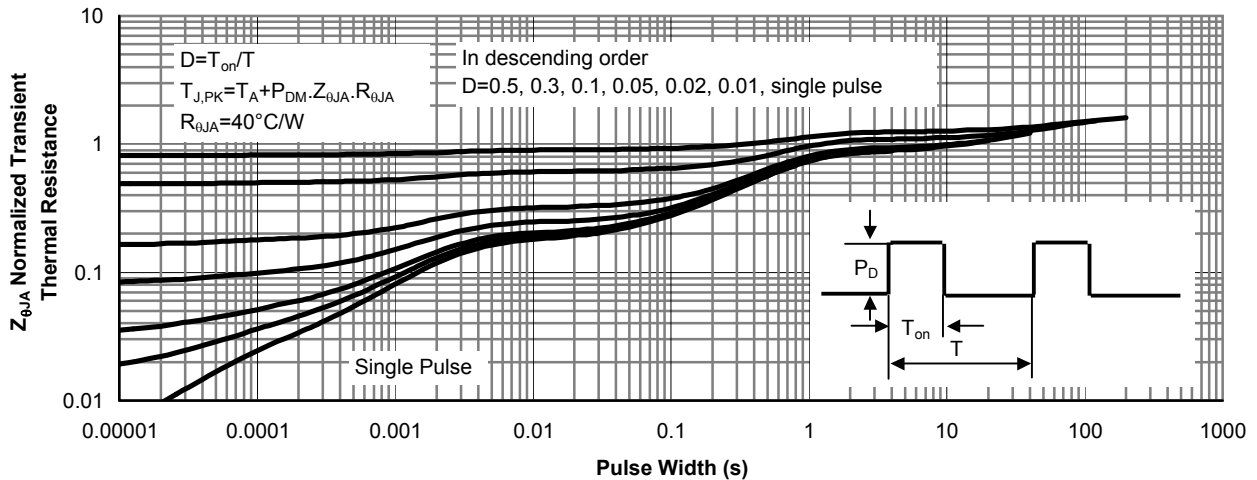


Figure 15: Schottky Normalized Maximum Transient Thermal Impedance